

# N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)		
30	0.0055 at V <sub>GS</sub> = 10 V	70	31 nC		
	0.0071 at V <sub>GS</sub> = 4.5 V	55	31110		

## **FEATURES**



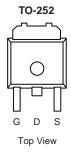


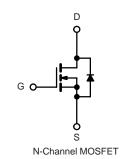
• 100 % Avalanche Tested



#### **APPLICATIONS**

- Low-Side Switch for DC/DC Converters
  - Servers
  - POL
  - VRM
- OR-ing





Parameter		Symbol	Limit	Unit
Drain-Source Voltage		$V_{DS}$	30	V
Gate-Source Voltage		$V_{GS}$	± 20	
	T <sub>C</sub> = 25 °C		70	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>C</sub> = 70 °C	L	55	
Continuous Dialii Current (1, = 150°C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	29 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		24 <sup>b, c</sup>	A
Pulsed Drain Current		I <sub>DM</sub>	200	_ ^
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>-</sub>	70	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	5.3 <sup>b, c</sup>	
Single Pulse Avalanche Current	L = 0.1 mH		68	
Single Pulse Avalanche Energy	L=0.11IIII	E <sub>AS</sub>	119	mJ
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		78	
	T <sub>C</sub> = 70 °C	P <sub>D</sub>	50	W
	T <sub>A</sub> = 25 °C	' D	5.1 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		3.2 <sup>b, c</sup>	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C
Soldering Recommendations (Peak Temperature)			260	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient	t ≤ 10 s	R <sub>thJA</sub>	20	25	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	1.0	1.5	C/VV	

- a. Based on T<sub>C</sub> = 25 °C. b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.



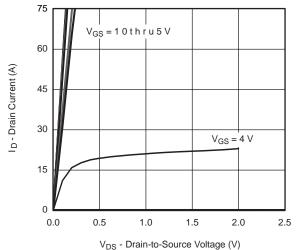
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V, } I_D = 250  \mu\text{A}$	30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 uA		28		m\//°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 6.6		mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.0		3.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Cata Valtana Dania O amand	I <sub>DSS</sub>	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V			1	μА	
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
	Б	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A		0.0055	0.0073	Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$		0.0071	0.0097		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 10 \text{ V}, I_{D} = 20 \text{ A}$		100		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			1960		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		670			
Reverse Transfer Capacitance	C <sub>rss</sub>			225			
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A		72	105	nC	
		20 1 00 12		31	48		
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 20 \text{ A}$		11			
Gate-Drain Charge	$Q_{gd}$			10			
Gate Resistance	$R_{g}$	f = 1 MHz	0.2	0.8	1.6	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			20			
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 1.5 $\Omega$		6			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ 10 A, $V_{GEN}$ = 10 V, $R_g$ = 1 $\Omega$		43			
Fall Time	t <sub>f</sub>			7			
Turn-On Delay Time	t <sub>d(on)</sub>			44		ns	
Rise Time	t <sub>r</sub>	$V_{DD} = 10 \text{ V}, R_L = 1 \Omega$		19			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		63			
Fall Time	t <sub>f</sub>			31			
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			70	^	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				200	A	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 4 A		0.7	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			33	55	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 10 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		25	43	nC	
Reverse Recovery Fall Time	t <sub>a</sub>			16		ns	
Reverse Recovery Rise Time	t <sub>b</sub>			17			

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$  b. Guaranteed by design, not subject to production testing.

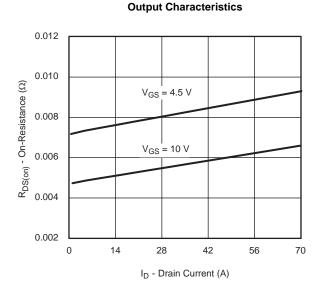
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



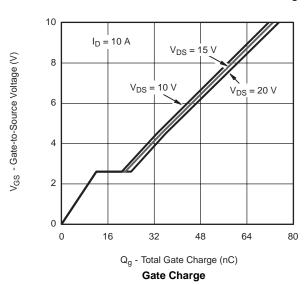
### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

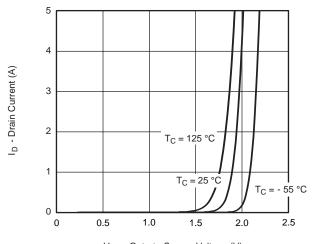


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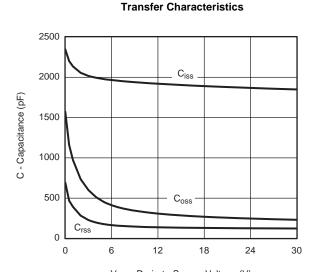


On-Resistance vs. Drain Current and Gate Voltage

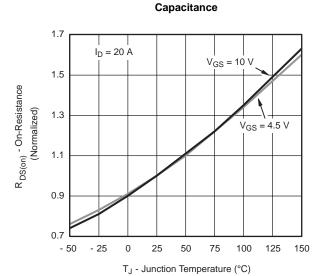




V<sub>GS</sub> - Gate-to-Source Voltage (V)

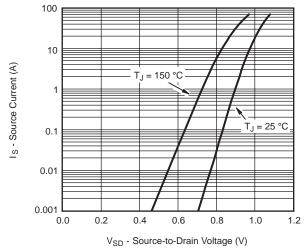


 $V_{\mbox{\footnotesize{DS}}}$  - Drain-to-Source Voltage (V)

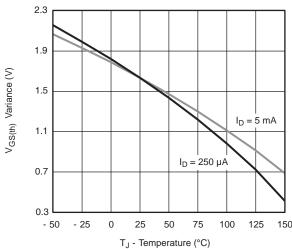


On-Resistance vs. Junction Temperature

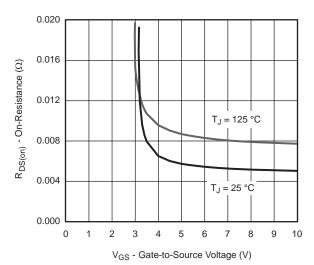
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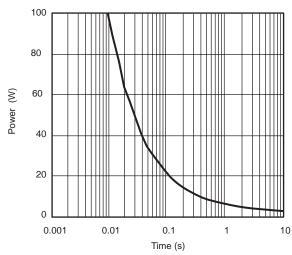
#### Source-Drain Diode Forward Voltage



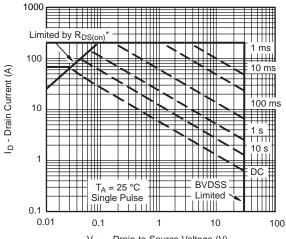
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

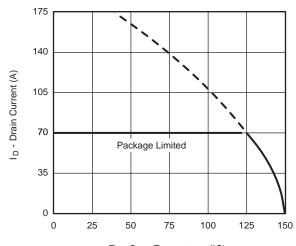


V<sub>DS</sub> - Drain-to-Source Voltage (V)

<sup>\*</sup>  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

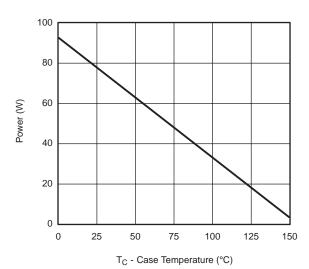


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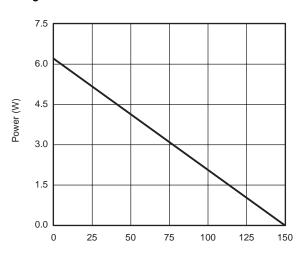


T<sub>C</sub> - Case Temperature (°C)

#### **Current Derating\***





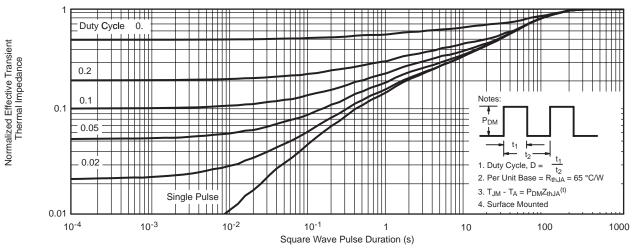


 $T_C$  - Case Temperature (°C) Power, Junction-to-Ambient

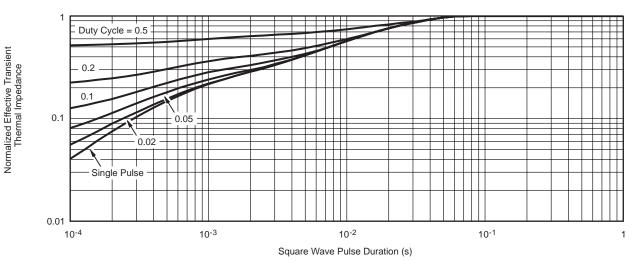
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit



### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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